



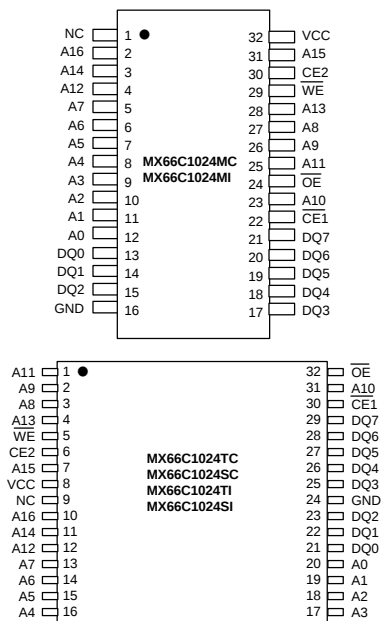
MX66C1024

5V Low Power CMOS SRAM 128 x 8 Bit

■ FEATURES

- Vcc operation voltage : 5V
- Low power consumption :
 - 45mA (Max.) write current
 - 2mA (Max.) read current
 - 0.6uA (Typ.) CMOS standby current
- High speed access time :
 - 70 70ns (Max.)
 - 10 100ns (Max.)
- Input levels are CMOS-compatible
- Automatic power down when chip is deselected
- Three state outputs
- Fully static operation
- Data retention supply voltage as low as 1.2V
- Easy expansion with CE2, CE1, and OE options

■ PIN CONFIGURATIONS



■ DESCRIPTION

The MX66C1024 is a high performance, extremely low power CMOS

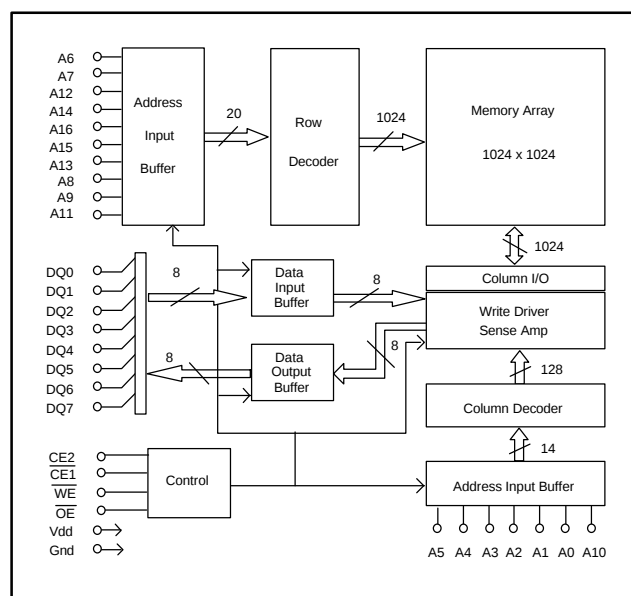
Static Random Access Memory organized as 131,072 words by 8 bits and operates at 5.0V supply voltage.

Advanced CMOS technology and circuit techniques provide both high speed and low power features with a typical CMOS standby current of 0.005uA and maximum access time of 70ns and 100ns. Easy memory expansion is provided by an active LOW chip enable (CE1), an active HIGH chip enable (CE2), and active LOW output enable (OE) and three-state output drivers.

The MX66C1024 has an automatic power down feature, reducing the power consumption significantly when chip is deselected.

The MX66C1024 is available in the JEDEC standard 32 pin SOP, STSOP and TSOP.

■ BLOCK DIAGRAM





■ PIN DESCRIPTIONS

Name	Function
A0-A16 Address Input	These 17 address input select one of the 131,072 x 8-bit words in the RAM
$\overline{\text{CE1}}$ Chip Enable 1 Input $\overline{\text{CE2}}$ Chip Enable 2 Input	$\overline{\text{CE1}}$ is active LOW and CE2 is active HIGH. Both chip enables must be active to read from or write to the device. If either chip enable is not active, the device is deselected and is in a standby power mode. The DQ pins will be in the high impedance state when the device is deselected.
$\overline{\text{WE}}$ Write Enable Input	The write enable input is active LOW and controls read and write operations. With the chip selected, when $\overline{\text{WE}}$ is HIGH and $\overline{\text{OE}}$ is LOW, output data will be present on the DQ pins; when $\overline{\text{WE}}$ is LOW, the data present on the DQ pins will be written into the selected memory location.
$\overline{\text{OE}}$ Output Enable Input	The output enable input is active LOW. If the output enable is active while the chip is selected and the write enable is inactive, data will be present on the DQ pins and they will be enabled. The DQ pins will be in the high impedance state when $\overline{\text{OE}}$ is inactive.
DQ0 – DQ7 Data Input/Output Ports	These 8 bi-directional ports are used to read data from or write data into the RAM.
Vcc	Power Supply
Gnd	Ground

■ TRUTH TABLE

MODE	$\overline{\text{WE}}$	$\overline{\text{CE1}}$	CE2	$\overline{\text{OE}}$	I/O OPERATION	Vcc CURRENT
Not selected (Power Down)	X	H	X	X	High Z	$I_{\text{CCSB}}, I_{\text{CCSB1}}$
	X	X	L	X		
Output Disabled	H	L	H	H	High Z	I_{CC}
Read	H	L	H	L	DOUT	I_{CC}
Write	L	L	H	X	DIN	I_{CC}

■ ABSOLUTE MAXIMUM RATINGS⁽¹⁾

SYMBOL	PARAMETER	RATING	UNITS
V _{TERM}	Terminal Voltage with Respect to GND	-0.5 to +7.0	V
T _{BIAS}	Temperature Under Bias	-40 to +125	°C
T _{STG}	Storage Temperature	-60 to +150	°C
P _T	Power Dissipation	1.0	W
I _{OUT}	DC Output Current	20	mA

1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

■ OPERATING RANGE

RANGE	AMBIENT TEMPERATURE
Commercial	0°C to +70°C
Industrial	-40°C to +70°C

■ CAPACITANCE ⁽¹⁾ (TA = 25°C, f = 1.0 MHz)

SYMBOL	PARAMETER	CONDITIONS	MAX.	UNIT
C _{IN}	Input Capacitance	V _{IN} =0V	6	pF
C _{DQ}	Input/Output Capacitance	V _{I/O} =0V	8	pF

1. This parameter is guaranteed and not tested.



■ DC ELECTRICAL CHARACTERISTICS (TA = 0 to + 70°C)

PARAMETER NAME	PARAMETER	TEST CONDITIONS	MIN.	TYP. ⁽¹⁾	MAX.	UNITS
V _{IL}	Guaranteed Input Low Voltage ⁽²⁾		-0.5	--	0.8	V
V _{IH}	Guaranteed Input High Voltage ⁽²⁾		2.2	--	V _{CC} +0.5	V
I _{IL}	Input Leakage Current	V _{CC} = Max, V _{IN} = 0V to V _{CC}	--	--	1	μA
I _{OL}	Output Leakage Current	V _{CC} = Max, $\overline{CE1} = V_{IH}$, CE2 = V _{IL} or OE = V _{IH} , V _{IO} = 0V to V _{CC}	--	--	1	μA
V _{OL}	Output Low Voltage	V _{CC} = Max, I _{OL} = 1mA	--	--	0.4	V
V _{OH}	Output High Voltage	V _{CC} = Min, I _{OH} = -0.5mA	2.4	--	--	V
I _{CC}	Operating Power Supply Current	$\overline{CE1} = V_{IL}$, or CE2 = V _{IH} , V _{CC} = 5.0 V I _{DQ} = 0mA, F = F _{max} ⁽³⁾	--	--	45	mA
I _{CCSB}	Standby Power Supply Current	$\overline{CE1} = V_{IH}$, or CE2 = V _{IL} , V _{CC} = 5.0 V I _{DQ} = 0mA, F = F _{max} ⁽³⁾	--	--	2	mA
I _{CCSB1}	Power Down Supply Current	$\overline{CE1} \geq V_{CC}-0.2V$, CE2 $\leq 0.2V$, V _{IN} $\geq V_{CC}-0.2V$ or V _{IN} $\leq 0.2V$	--	0.6	3	μA

1. Typical characteristics are at TA = 25°C.

2. These are absolute values with respect to device ground and all overshoots due to system or tester noise are included.

3. F_{max} = 1/t_{RC}.

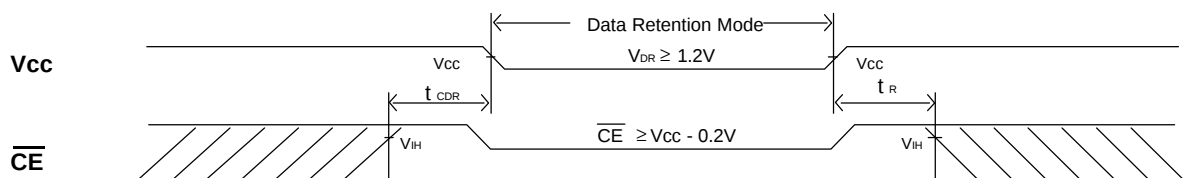
■ DATA RETENTION CHARACTERISTICS (TA = 0 to + 70°C)

SYMBOL	PARAMETER	TEST CONDITIONS	MIN.	TYP. ⁽¹⁾	MAX.	UNITS
V _{DR}	V _{CC} for Data Retention	$\overline{CE1} \geq V_{CC} - 0.2V$, CE2 $\leq 0.2V$, VIN $\geq V_{CC} - 0.2V$ or VIN $\leq 0.2V$	1.2	--	--	V
I _{CCDR}	Data Retention Current	$\overline{CE1} \geq V_{CC} - 0.2V$, CE2 $\leq 0.2V$, VIN $\geq V_{CC} - 0.2V$ or VIN $\leq 0.2V$	--	0.005	0.2	μA
t _{CDR}	Chip Deselect to Data Retention Time	See Retention Waveform	0	--	--	ns
t _R	Operation Recovery Time		T _{RC} ⁽²⁾	--	--	ns

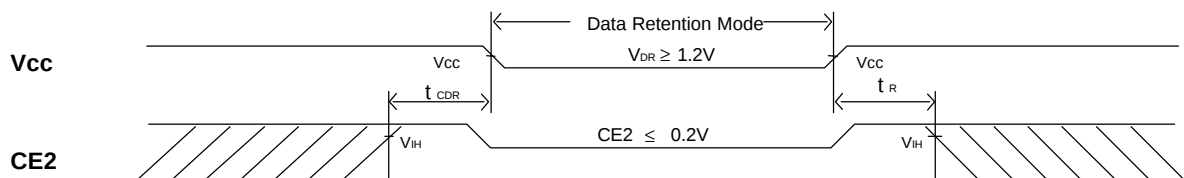
1. V_{CC} = 1.5V, T_A = + 25°C

2. t_{RC} = Read Cycle Time

■ LOW V_{CC} DATA RETENTION WAVEFORM (1) ($\overline{CE1}$ Controlled)



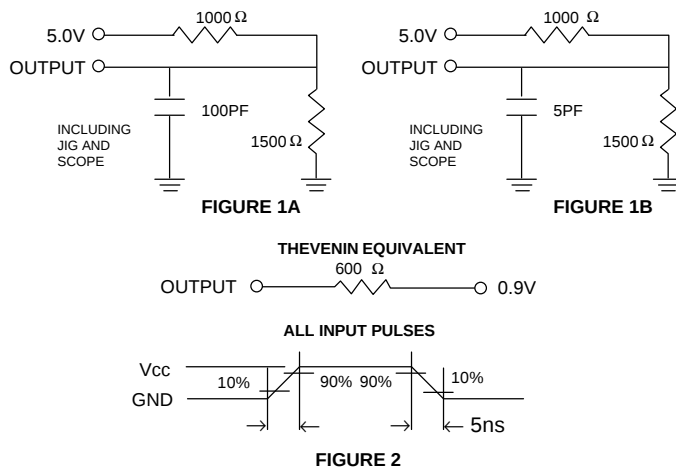
■ LOW V_{CC} DATA RETENTION WAVEFORM (2) (CE2 Controlled)



■ AC TEST CONDITIONS

Input Pulse Levels	Vcc/0V
Input Rise and Fall Times	5ns
Input and Output Timing Reference Level	0.5Vcc

■ AC TEST LOADS AND WAVEFORMS



■ KEY TO SWITCHING WAVEFORMS

WAVEFORM	INPUTS	OUTPUTS
	MUST BE STEADY	MUST BE STEADY
	MAY CHANGE FROM H TO L	WILL BE CHANGE FROM H TO L
	MAY CHANGE FROM L TO H	WILL BE CHANGE FROM L TO H
	DON'T CARE: ANY CHANGE PERMITTED	CHANGE : STATE UNKNOWN
	DOES NOT APPLY	CENTER LINE IS HIGH IMPEDANCE "OFF" STATE

■ AC ELECTRICAL CHARACTERISTICS (over the operating range)

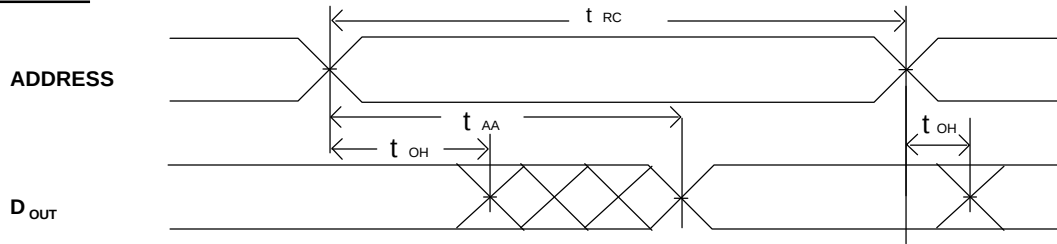
READ CYCLE

JEDEC PARAMETER NAME	PARAMETER NAME	DESCRIPTION	MX66C1024-70 MIN. TYP. MAX.			MX66C1024-10 MIN. TYP. MAX.			UNIT
t_{AVAX}	t_{RC}	Read Cycle Time	70	--	--	100	--	--	ns
t_{AVQV}	t_{AA}	Address Access Time	--	--	70	--	--	100	ns
t_{E1LQV}	t_{ACS1}	Chip Select Access Time ($\overline{CE1}$)	--	--	70	--	--	100	ns
t_{E2HOV}	t_{ACS2}	Chip Select Access Time (CE2)	--	--	70	--	--	100	ns
t_{GLQV}	t_{OE}	Output Enable to Output Valid	--	--	50	--	--	50	ns
t_{E1LQX}	t_{CLZ1}	Chip Select to Output Low Z ($\overline{CE1}$)	10	--	--	10	--	--	ns
t_{E2HOX}	t_{CLZ2}	Chip Select to Output Low Z (CE2)	10	--	--	10	--	--	ns
t_{GLQX}	t_{OLZ}	Output Enable to Output in Low Z	10	--	--	10	--	--	ns
t_{E1HQZ}	t_{CHZ1}	Chip Deselect to Output in High Z ($\overline{CE1}$)	0	--	40	0	--	40	ns
t_{E2HQZ}	t_{CHZ1}	Chip Deselect to Output in High Z (CE2)	0	--	40	0	--	40	ns
t_{GHQZ}	t_{OHZ}	Output Disable to Output in High Z	0	--	35	0	--	35	ns
t_{AXOX}	t_{OH}	Output Disable to Output Address Change	10	--	--	10	--	--	ns

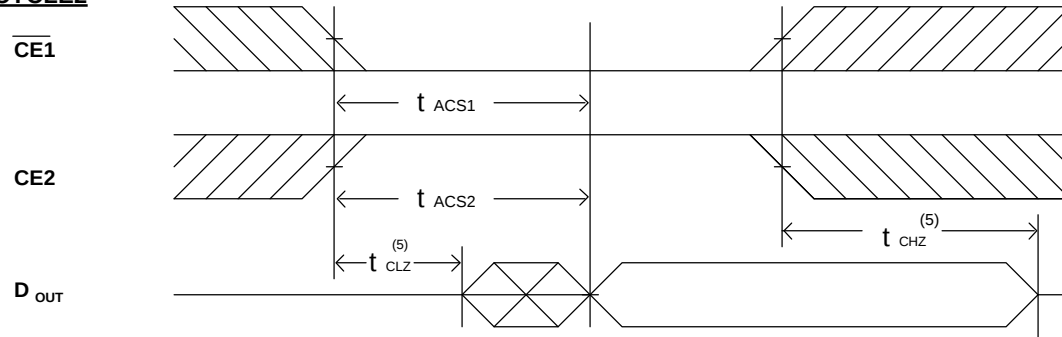
1. Typical characteristics are at Vcc = 5V, TA = 25°C.

■ SWITCHING WAVEFORMS (READ CYCLE)

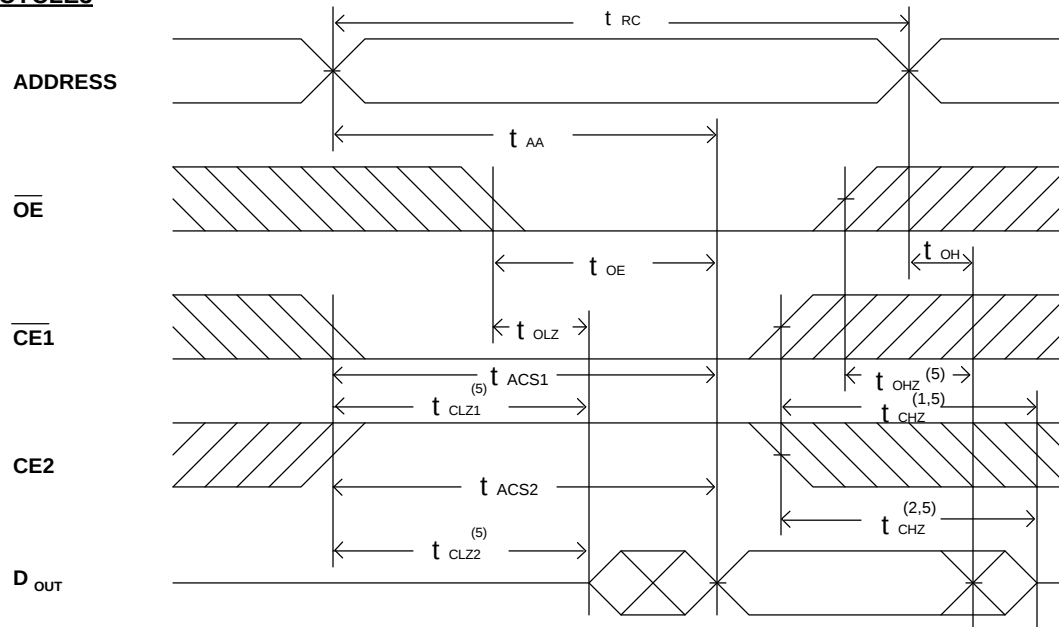
READ CYCLE1 (1,2,4)



READ CYCLE2 (1,3,4)



READ CYCLE3 (1,4)



NOTES:

1. WE is high for read Cycle.
2. Device is continuously selected when $\overline{CE1} = V_{IL}$ and $CE2 = V_{IH}$.
3. Address valid prior to or coincident with $\overline{CE1}$ transition low and/or CE2 transition high.
4. $\overline{OE} = V_{IL}$.
5. Transition is measured $\pm 500mV$ from steady state with $C_L = 5pF$ as shown in Figure 1B. The parameter is guaranteed but not 100% tested.



MX66C1024

■ AC ELECTRICAL CHARACTERISTICS (over the operating range)

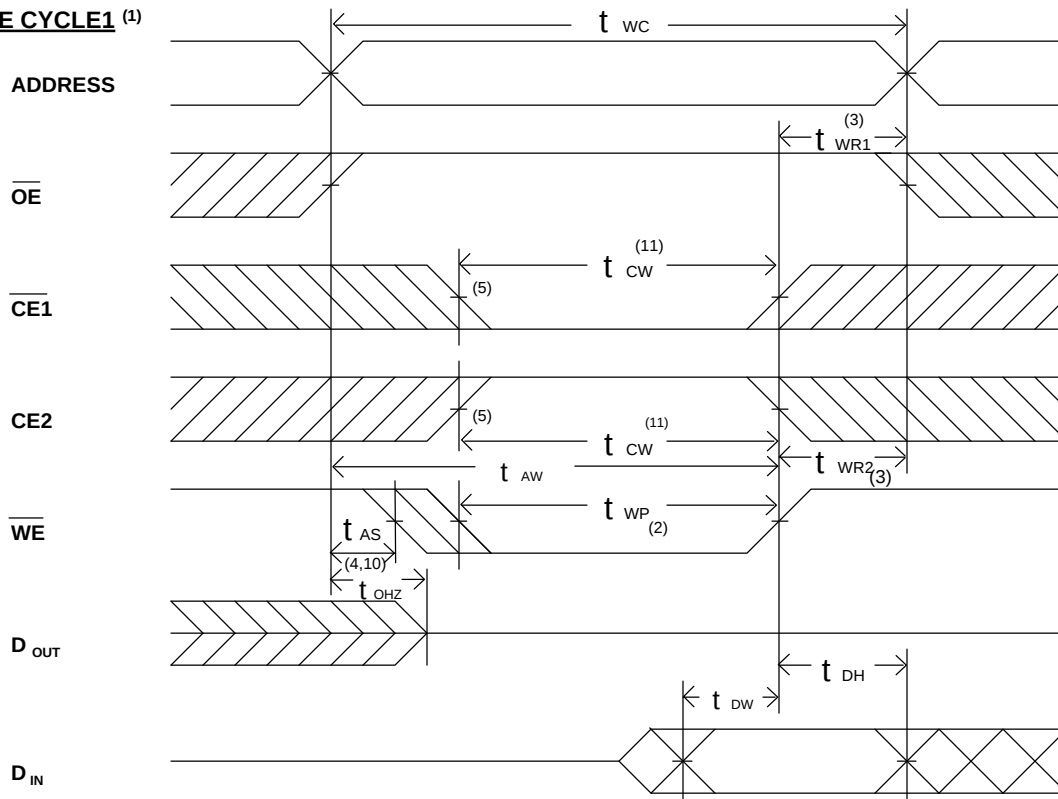
WRITE CYCLE

JEDEC PARAMETER NAME	PARAMETER NAME	DESCRIPTION	MX66C1024-70			MX66C1024-10			UNIT
			MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
t			70	--	--	100	--	--	ns
t_{E1LWH}	t_{CW}	Chip Select to End of Write	70	--	--	100	--	--	ns
t_{AVWL}	t_{AS}	Address Set up Time	0	--	--	0	--	--	ns
t_{AVWH}	t_{AW}	Address Valid to End of Write	70	--	--	10	--	--	ns
t_{WLWH}	t_{WP}	Write Pulse Width	50	--	--	50	--	--	ns
t_{WHAX}	t_{WR1}	Write Recovery Time (CE1, WE)	0	--	--	--	--	--	ns
t_{E2LAX}	t_{WR2}	Write Recovery Time (CE2)	0	--	--	--	--	--	ns
t_{WLOZ}	t_{WHZ}	Write to Output in High Z	--	--	30	--	--	30	ns
t_{DVWH}	t_{DW}	Data to Write Time Overlap	30	--	--	30	--	--	ns
t_{WHDX}	t_{DH}	Data Hold from Write Time	0	--	--	0	--	--	ns
t_{GHOZ}	t_{OHZ}	Output Disable to Output in High Z	0	--	30	0	--	30	ns
t_{WHQX}	t_{OW}	End of Write to Output Active	5	--	--	5	--	--	ns

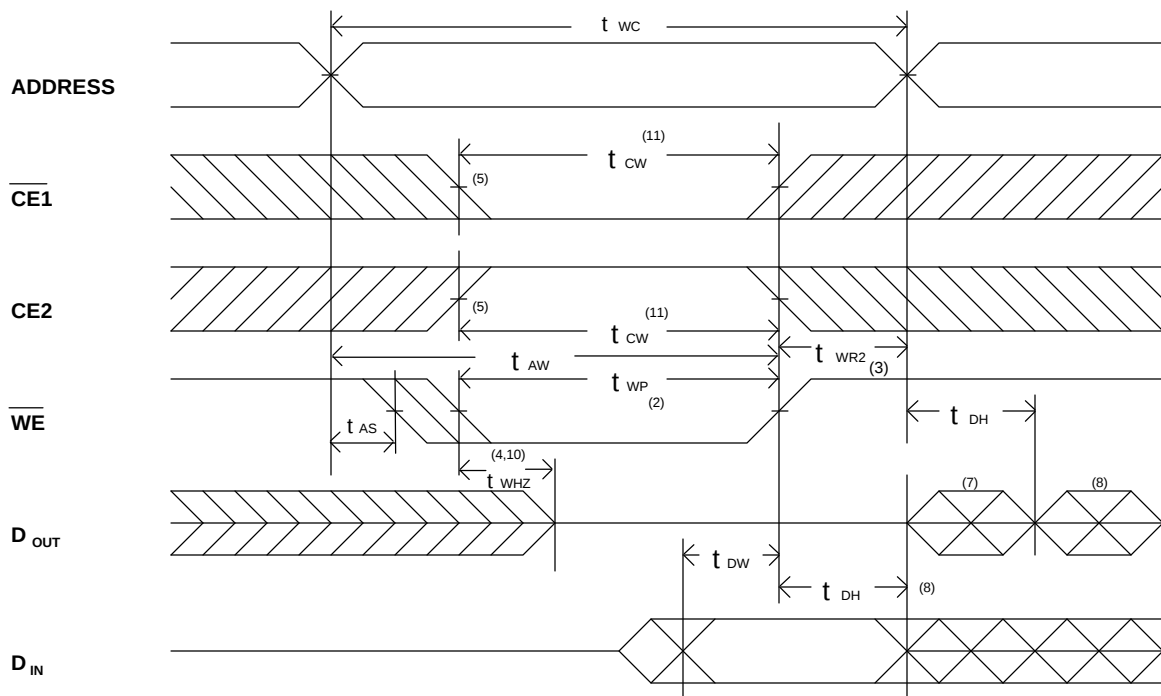
1. Typical characteristics are at $V_{CC} = 5V$, $T_A = 25^\circ C$.

■ SWITCHING WAVEFORMS (WRITE CYCLE)

WRITE CYCLE1⁽¹⁾



WRITE CYCLE2 ^(1,6)

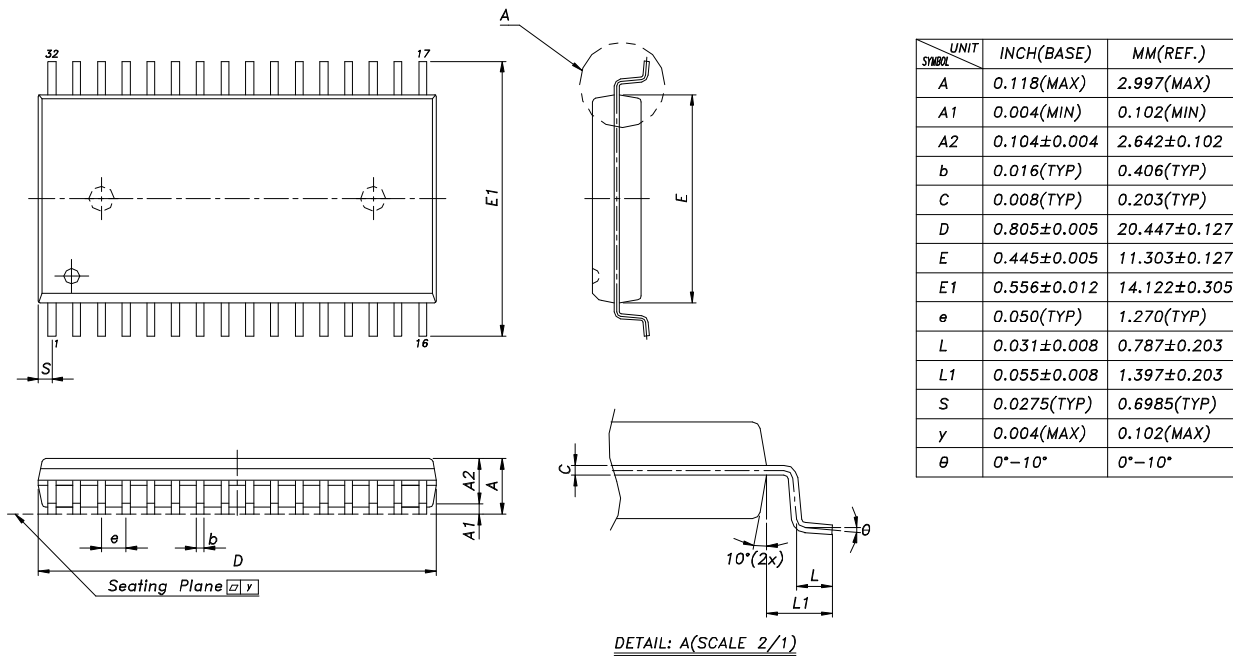


NOTES:

1. $\overline{WE}$ must be high during address transitions.
2. The internal write time of the memory is defined by the overlap of $\overline{CE1}$ and $\overline{CE2}$ active and $\overline{WE}$ low. All signals must be active to initiate a write and any one signal can terminate a write by going inactive. The data input setup and hold timing should be referenced to the second transition edge of the signal that terminates the write.
3. T_{WR} is measured from the earlier of $\overline{CE1}$ or $\overline{WE}$ going high or $\overline{CE2}$ going low at the end of write cycle.
4. During this period, DQ pins are in the output state so that the input signals of opposite phase to the outputs must not be applied.
5. If the $\overline{CE1}$ low transition or the $\overline{CE2}$ high transition occurs simultaneously with the $\overline{WE}$ low transitions or after the $\overline{WE}$ transition, output remain in a high impedance state.
6. $\overline{OE}$ is continuously low ($\overline{OE} = V_{IL}$).
7. D_{OUT} is the same phase of write data of this write cycle.
8. D_{OUT} is the read data of next address.
9. If $\overline{CE1}$ is low and $\overline{CE2}$ is high during this period, DQ pins are in the output state. Then the data input signals of opposite phase to the outputs must not be applied to them.
10. Transition is measured $\pm 500\text{mV}$ from steady state with $C_L = 5\text{pF}$ as shown in Figure 1B. The parameter is guaranteed but not 100% tested.
11. T_{CW} is measured from the later of $\overline{CE1}$ going low or $\overline{CE2}$ going high to the end of write.

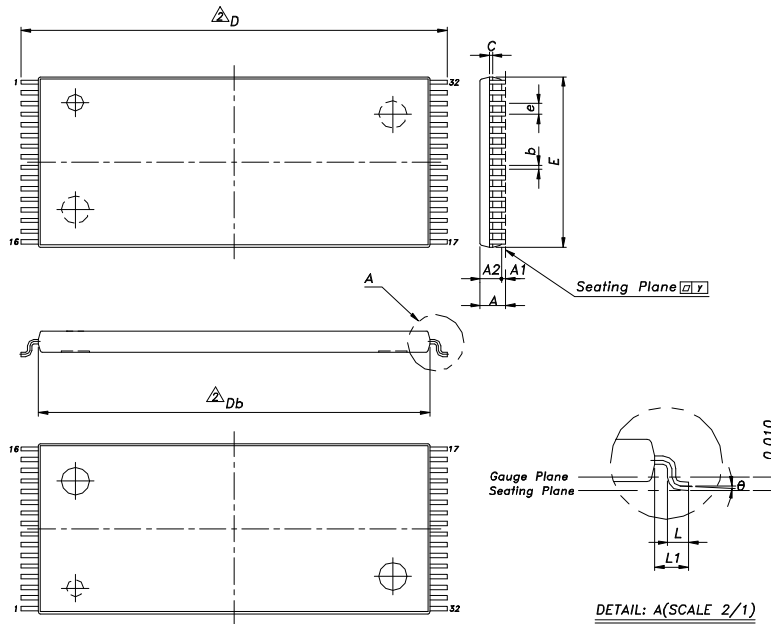
SPEED (ns)	ORDERING PART NUMBER	PACKAGE	TEMPERATURE RANGE
70	MX66C1024MC - 70	SOP - 32 PIN	0° C to + 70° C
100	MX66C1024MC - 10	SOP - 32 PIN	0° C to + 70° C
70	MX66C1024MI - 70	SOP - 32 PIN	-40° C to + 85° C
100	MX66C1024MI - 10	SOP - 32 PIN	-40° C to + 85° C
70	MX66C1024TC - 70	TSOP - 32 PIN	0° C to + 70° C
100	MX66C1024TC - 10	TSOP - 32 PIN	0° C to + 70° C
70	MX66C1024TI- 70	TSOP - 32 PIN	-40° C to + 85° C
100	MX66C1024TI- 10	TSOP - 32 PIN	-40° C to + 85° C
70	MX66C1024SC- 70	STSOP - 32 PIN	0° C to + 70° C
100	MX66C1024SC- 10	STSOP - 32 PIN	0° C to + 70° C
70	MX66C1024SI- 70	STSOP - 32 PIN	-40° C to + 85° C
100	MX66C1024SI- 10	STSOP - 32 PIN	-40° C to + 85° C

■ PACKAGE DIMENSIONS



SOP-32

■ PACKAGE DIMENSIONS (continued)



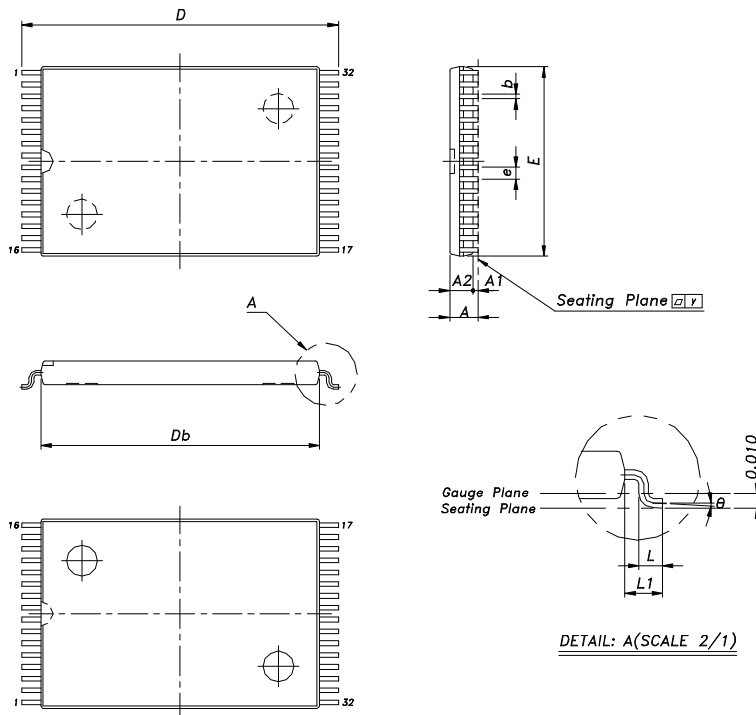
UNIT SYMBOL	INCH(BASE)	MM(REF.)
A	0.047(MAX)	1.20(MAX)
A1	0.004±0.002	0.10±0.05
A2	0.039±0.002	1.00±0.05
b	0.008(TYP)	0.20(TYP)
C	0.006(TYP)	0.15(TYP)
Db	0.724±0.004	18.40±0.10
E	0.315±0.004	8.00±0.10
e	0.020(TYP)	0.50(TYP)
D	0.787±0.008	20.00±0.20
L1	0.0315±0.004	0.80±0.10
y	0.004(MAX)	0.102(MAX)
θ	0°-5°	0°-5°

(Option 1)

L	0.020±0.004	0.50±0.10
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(Option 2)

L	0.024±0.004	0.60±0.10
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UNIT SYMBOL	INCH(BASE)	MM(REF.)
A	0.047(MAX)	1.20(MAX)
A1	0.004±0.002	0.10±0.05
A2	0.039±0.002	1.00±0.05
b	0.008(TYP)	0.20(TYP)
C	0.006(TYP)	0.15(TYP)
Db	0.465±0.004	11.80±0.10
E	0.315±0.004	8.00±0.10
e	0.020(TYP)	0.50(TYP)
D	0.528±0.008	13.40±0.20
L	0.020±0.004	0.50±0.10
L1	0.0315±0.004	0.80±0.10
y	0.004(MAX)	0.102(MAX)
θ	0°-5°	0°-5°



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